 Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/081,968	FUJINO ET AL.	
Examiner	Art Unit	
Jacob Y. Choi	2875	

	SEAR	CHED	
Class	Subclass	Date	Examiner
362	31, 331, 261, 339, 26	4/27/2005	JC
385	49, 88	4/27/2005	JC
385	146	4/27/2005	JC
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TNI	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
Class/Subclass Search 362 - John Ward	4/26/2005	JC
385 - John Lee	4/26/2005	1C
Text Search performed by the examiner	4/27/2005	JC
Updated Search Conducted by Examiner	11/13/2005	JC
Updated Search Conducted by Examiner	3/28/2006	JC
Updated Search Conducted by Examiner	10/6/2006	JC